

STF7N60M2

Datasheet - production data

N-channel 600 V, 0.86 Ω typ., 5 A MDmesh II Plus™ low Q_g Power MOSFET in TO-220FP package

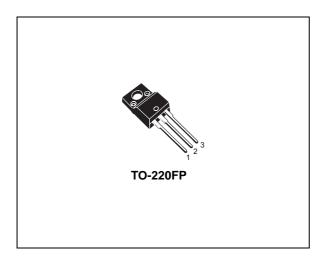
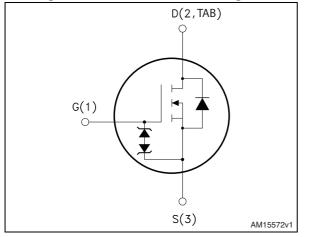


Figure 1. Internal schematic diagram



Features

Order code	V _{DS} @ T _{Jmax}	R _{DS(on)} max	I _D
STF7N60M2	650 V	0.95 Ω	5 A

- Extremely low gate charge
- Lower R_{DS(on)} x area vs previous generation
- Low gate input resistance
- 100% avalanche tested
- Zener-protected

Applications

• Switching applications

Description

This device is an N-channel Power MOSFET developed using a new generation of MDmeshTM technology: MDmesh II PlusTM low Q_g . This revolutionary Power MOSFET associates a vertical structure to the company's strip layout to yield one of the world's lowest on-resistance and gate charge. It is therefore suitable for the most demanding high efficiency converters.

Order code	Marking	Package	Packaging
STF7N60M2	7N60M2	TO-220FP	Tube

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This is information on a product in full production.

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1 Electrical ratings

Symbol	Parameter	Value	Unit
V _{GS}	Gate-source voltage	± 25	V
Ι _D	Drain current (continuous) at T _C = 25 °C	5 ⁽¹⁾	А
Ι _D	Drain current (continuous) at T _C = 100 °C	3.5 ⁽¹⁾	А
I _{DM} ⁽¹⁾	Drain current (pulsed)	20 ⁽¹⁾	А
P _{TOT}	Total dissipation at $T_C = 25 \ ^{\circ}C$	20	W
V _{ISO}	Insulation withstand voltage (RMS) from all three leads to external heat sink (t=1 s; $T_C=25$ °C)	2500	V
dv/dt ⁽²⁾	Peak diode recovery voltage slope	15	V/ns
dv/dt ⁽³⁾	MOSFET dv/dt ruggedness	50 V/n	
T _{stg}	Storage temperature	55 to 150	℃
Тj	Max. operating junction temperature	- 55 to 150	

Table 2. Absolute maximum ratings	solute maximum ratin	qs
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1. Pulse width limited by safe operating area.

2. $I_{SD} \leq$ 5 A, di/dt \leq 400 A/µs; V_{DS peak} < V_{(BR)DSS}, V_{DD}=400 V

3. $V_{DS} \leq 480 \text{ V}$

Table 3. Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case max	6.25	°C/W
R _{thj-amb}	Thermal resistance junction-ambient max	62.5	°C/W

Table 4. Avalanche characteristics

Symbol	Parameter	Value	Unit
I _{AR}	Avalanche current, repetitive or not repetitive (pulse width limited by T_{jmax})	1.5	A
E _{AS}	Single pulse avalanche energy (starting T_j =25°C, I_D = I_{AR} ; V_{DD} =50)	99	mJ



2 Electrical characteristics

(T_C = 25 °C unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	I _D = 1 mA, V _{GS} = 0	600			V
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	V _{DS} = 600 V V _{DS} = 600 V, T _C =125 °C			1 100	μA μA
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	V _{GS} = ± 25 V			±10	μA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	2	3	4	V
R _{DS(on)}	Static drain-source on-resistance	V _{GS} = 10 V, I _D = 2.5 A		0.86	0.95	Ω

Table	5.	On	/off	states
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Table 6. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss}	Input capacitance		-	271	-	pF
C _{oss}	Output capacitance	V _{DS} = 100 V, f = 1 MHz,	-	15.7	-	pF
C _{rss}	Reverse transfer capacitance	V _{GS} = 0	-	0.68	-	pF
C _{oss eq.} ⁽¹⁾	Equivalent output capacitance	$V_{DS} = 0$ to 480 V, $V_{GS} = 0$	-	75.5	-	pF
R _G	Intrinsic gate resistance	f = 1 MHz open drain	-	7.2	-	Ω
Qg	Total gate charge	V _{DD} = 480 V, I _D = 5 A,	-	8.8	-	nC
Q _{gs}	Gate-source charge	V _{GS} = 10 V	-	1.8	-	nC
Q _{gd}	Gate-drain charge	(see Figure 15)	-	4.3	-	nC

1. $C_{oss eq.}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}

Table 7	7. Switcl	hing times
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Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time	$V_{DD} = 300 \text{ V}, I_D = 2.5 \text{ A},$ $R_G = 4.7 \Omega, V_{GS} = 10 \text{ V}$ (see <i>Figure 14</i> and <i>19</i>)	-	7.6	-	ns
t _r	Rise time		-	7.2	-	ns
t _{d(off)}	Turn-off delay time		-	19.3	-	ns
t _f	Fall time		-	15.9	-	ns



Symbol	Parameter	Test conditions	Min.	Turn	Max.	Unit
Symbol	Farailleter	lest conditions	wiin.	Тур.	wax.	Unit
I _{SD} I _{SDM} ⁽¹⁾	Source-drain current Source-drain current (pulsed)		-		5 20	A A
V _{SD} ⁽²⁾	Forward on voltage	$I_{SD} = 5 \text{ A}, V_{GS} = 0$	-		1.6	V
t _{rr}	Reverse recovery time		-	275		ns
Q _{rr}	Reverse recovery charge	I _{SD} = 5 A, di/dt = 100 A/μs V _{DD} = 60 V (see <i>Figure 19</i>)	-	1.55		nC
I _{RRM}	Reverse recovery current		-	11		А
t _{rr}	Reverse recovery time	I _{SD} = 5 A, di/dt = 100 A/µs	-	376		ns
Q _{rr}	Reverse recovery charge	$V_{DD} = 60 \text{ V}, \text{ T}_{j} = 150 \text{ °C}$	-	2.1		nC
I _{RRM}	Reverse recovery current	(see Figure 19)	-	11		А

Table 8. Source drain diode

1. Pulse width limited by safe operating area.

2. Pulsed: pulse duration = $300 \ \mu$ s, duty cycle 1.5%



2.1 Electrical characteristics (curves)

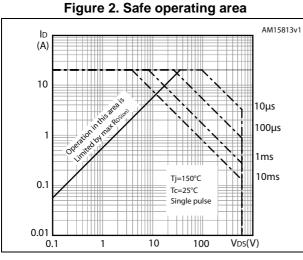
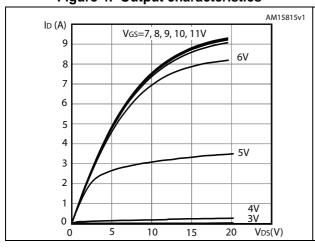
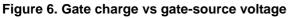
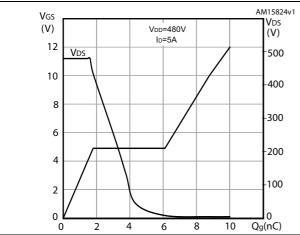


Figure 4. Output characteristics







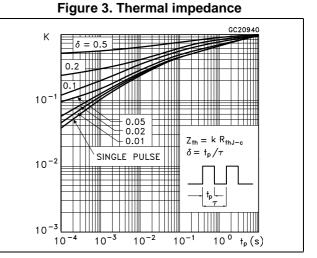
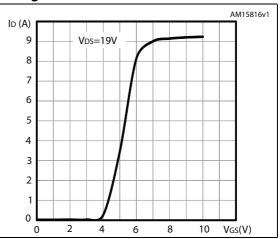
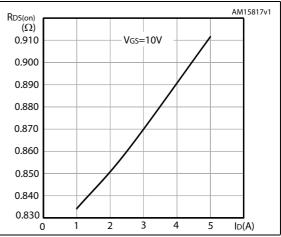


Figure 5. Transfer characteristics







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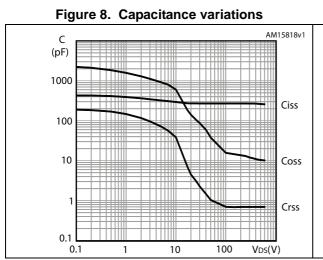


Figure 10. Normalized gate threshold voltage vs. temperature

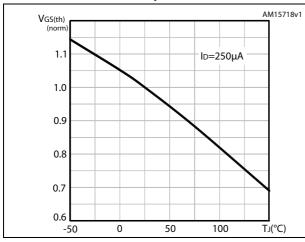


Figure 12. Drain-source diode forward characteristics

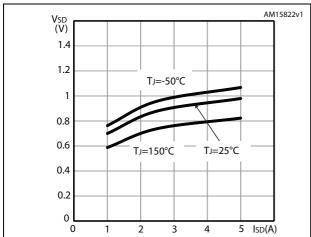


Figure 9. Output capacitance stored energy

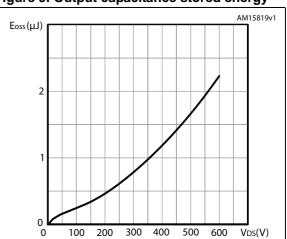


Figure 11. Normalized on-resistance vs. temperature

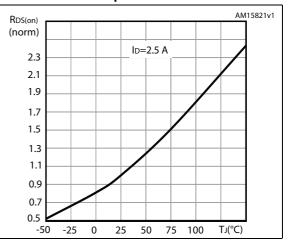
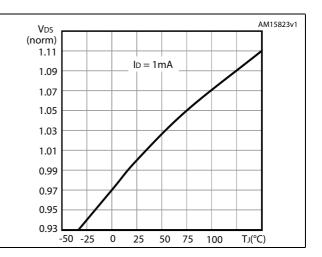


Figure 13. Normalized V_{DS} vs. temperature





3 Test circuits

Figure 14. Switching times test circuit for resistive load

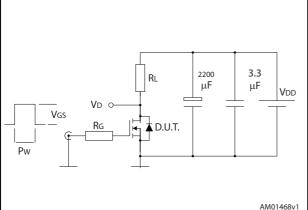


Figure 16. Test circuit for inductive load switching and diode recovery times

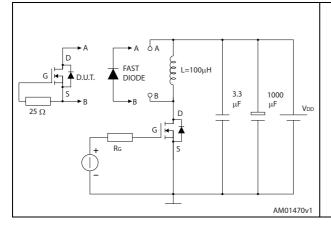


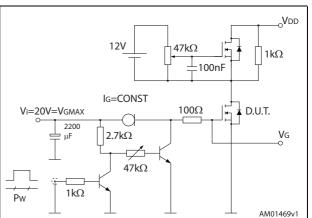
Figure 18. Unclamped inductive waveform

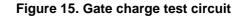
VD

ldм

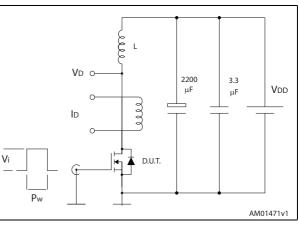
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V(BR)DSS









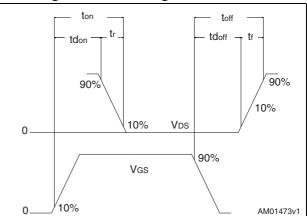


Figure 19. Switching time waveform



Vdd

AM01472v1



Vdd

4 Package mechanical data

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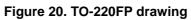


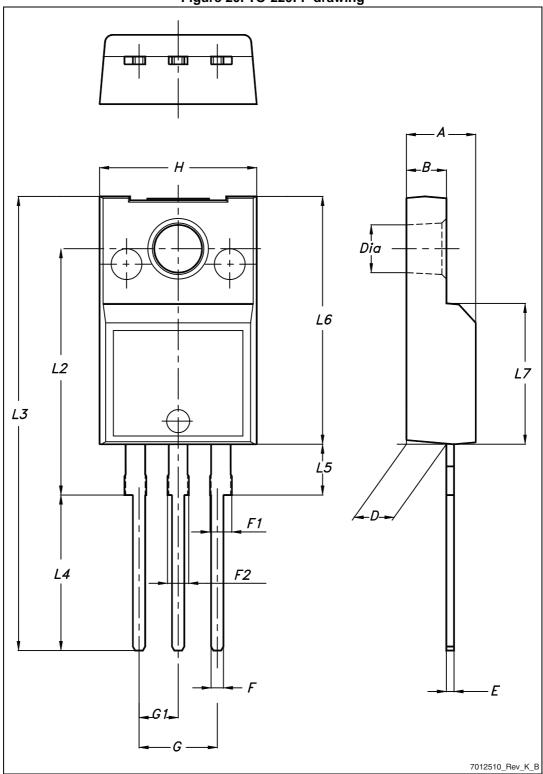
Package mechanical data

Table 9. TO-220FP mechanical data					
Dim.	mm				
	Min.	Тур.	Max.		
А	4.4		4.6		
В	2.5		2.7		
D	2.5		2.75		
Е	0.45		0.7		
F	0.75		1		
F1	1.15		1.70		
F2	1.15		1.70		
G	4.95		5.2		
G1	2.4		2.7		
Н	10		10.4		
L2		16			
L3	28.6		30.6		
L4	9.8		10.6		
L5	2.9		3.6		
L6	15.9		16.4		
L7	9		9.3		
Dia	3		3.2		

Table 9. TO-220FP mechanical data









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5 **Revision history**

Table 10. Document	revision history
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Table 10. Document revision history				
Date	Date Revision Changes			
26-Jun-2013	1	First release.		



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